

Notice of References Cited	Application/Control No. 10/700,328		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Keath T. Chen		Art Unit 1762	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,174,371	01-2001	Iseki et al.	118/689
*	B	US-5,372,754	12-1994	Ono, Hirofumi	261/142
*	C	US-4,685,331	08-1987	Renken et al.	73/204.15
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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